

**Search Notes**

Application/Control No.

10/813,367

Examiner

Chau N. Nguyen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2831

**SEARCHED**

Class	Subclass	Date	Examiner
174	102SC	4/21/2005	CN
	105SC		
	106Sc		
	120SC		
update	all	11/12/2007	CN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
see print out		11/12/2007	CN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text	4/21/2005	CN